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Nota di contenuto	Pt. 1. Phase Lock Without Noise. -- 1. Introduction (p. 3) -- 2. The Basic Loop (p. 15) -- 3. Loop Components (p. 29) -- 4. Loop Response (p. 59) -- 5. Loop Stability (p. 71) -- 6. Transient Response (p. 87) -- 7. Modulation Response (p. 111) -- 8. Acquisition (p. 137) -- 9. Acquisition Aids (p. 171) -- 10. Applications a Extensions (p. 189) -- Pt. 2. Phase Lock in Noise. -- 11. Phase Modulation By Noise (p. 233) -- 12. Response to Phase Noise (p. 251) -- 13. Representation of Additive Noise (p. 271) -- 14. Loop Response to Additive Noise (p. 287) -- 15. Phase-Locked Loop as a Demodulator (p. 297) -- 16. Parameter Variation Due to Noise (p. 319) -- 17. Cycle Skipping Due to Noise (p. 335) -- 18. Nonlinear Operation in a Locked Loop (p. 359) -- 19. Acquisition Aids in the Presence of Noise (p. 377) -- 20. Bandlimited Noise (p. 395) -- 21. Further Information (p. 415)
Sommario/riassunto	Broad-based and hands-on, Phase-Lock Basics, Second Edition is both easy to understand and easy to customize. The text can be used as a

theoretical introduction for graduate students or, when used with MATLAB simulation software, the book becomes a virtual laboratory for working professionals who want to improve their understanding of the design process and apply it to the demands of specific situations. This second edition features a large body of new statistical data obtained from simulations and uses available experimental data for confirmation of the simulation results.
